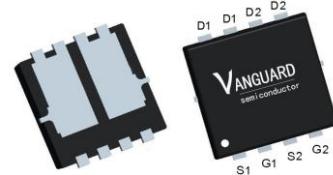


Features

- Dual N-Channel, 5V Logic Level Control
- Enhancement mode
- Low on-resistance $R_{DS(on)}$ @ $V_{GS}=4.5$ V
- Fast Switching
- 100% Avalanche Tested
- Pb-free lead plating; RoHS compliant

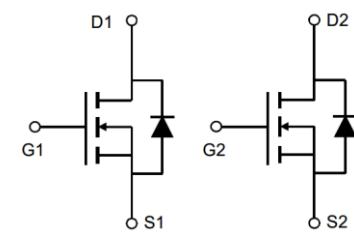
V_{DS}	30	V
$R_{DS(on),TYP}$ @ $V_{GS}=10$ V	14	$m\Omega$
$R_{DS(on),TYP}$ @ $V_{GS}=4.5$ V	22	$m\Omega$
I_D	30	A

PDFN5x6



Halogen-Free

Part ID	Package Type	Marking	Tape and reel information
VS3640DP	PDFN5x6	3640DP	3000pcs/Reel



Maximum ratings, at $T_A=25$ °C, unless otherwise specified

Symbol	Parameter	Rating	Unit
$V_{(BR)DSS}$	Drain-Source breakdown voltage	30	V
I_s	Diode continuous forward current	$T_c=25^\circ C$	A
I_D	Continuous drain current @ $V_{GS}=10V$	$T_c=25^\circ C$	A
		$T_c=100^\circ C$	A
I_{DM}	Pulse drain current tested ①	$T_c=25^\circ C$	A
EAS	Avalanche energy, single pulsed ②	15	mJ
P_d	Maximum power dissipation	$T_c=25^\circ C$	W
V_{GS}	Gate-Source voltage	± 20	V
T_{STG}	Storage temperature range	-55 to 150	°C

Thermal Characteristics

Symbol	Parameter	Typical	Unit
$R_{\theta JC}$	Thermal Resistance Junction-to-Case	7	°C/W
$R_{\theta JA}$	Thermal Resistance Junction-to-Ambient	50	°C/W



Typical Electrical Characteristics

Symbol	Parameter	Condition	Min.	Typ.	Max.	Unit
Static Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise stated)						
$V_{(\text{BR})\text{DSS}}$	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250\mu\text{A}$	30	--	--	V
I_{DSS}	Zero Gate Voltage Drain Current($T_c=25^\circ\text{C}$)	$V_{\text{DS}}=30\text{V}, V_{\text{GS}}=0\text{V}$	--	--	1	μA
	Zero Gate Voltage Drain Current($T_c=125^\circ\text{C}$)	$V_{\text{DS}}=30\text{V}, V_{\text{GS}}=0\text{V}$	--	--	100	μA
I_{GSS}	Gate-Body Leakage Current	$V_{\text{GS}}=\pm 20\text{V}, V_{\text{DS}}=0\text{V}$	--	--	± 100	nA
$V_{\text{GS(TH)}}$	Gate Threshold Voltage	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=250\mu\text{A}$	1.3	1.9	2.4	V
$R_{\text{DS(ON)}}$	Drain-Source On-State Resistance ③	$V_{\text{GS}}=10\text{V}, I_{\text{D}}=15\text{A}$	--	14	19	$\text{m}\Omega$
$R_{\text{DS(ON)}}$	Drain-Source On-State Resistance ③	$V_{\text{GS}}=4.5\text{V}, I_{\text{D}}=10\text{A}$	--	22	30	$\text{m}\Omega$
Dynamic Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise stated)						
C_{iss}	Input Capacitance	$V_{\text{DS}}=15\text{V}, V_{\text{GS}}=0\text{V}, f=1\text{MHz}$	300	450	550	pF
C_{oss}	Output Capacitance		--	75	150	pF
C_{rss}	Reverse Transfer Capacitance		--	60	120	pF
R_g	Gate Resistance	$f=1\text{MHz}$	--	3.7	--	Ω
Q_g	Total Gate Charge	$V_{\text{DS}}=15\text{V}, I_{\text{D}}=15\text{A}, V_{\text{GS}}=10\text{V}$	--	11.3	--	nC
Q_{qs}	Gate-Source Charge		--	3	--	nC
Q_{qd}	Gate-Drain Charge		--	4.3	--	nC
Switching Characteristics						
$t_{\text{d(on)}}$	Turn-on Delay Time	$V_{\text{DD}}=15\text{V}, I_{\text{D}}=15\text{A}, R_{\text{G}}=3\Omega, V_{\text{GS}}=10\text{V}$	--	7	--	nS
t_r	Turn-on Rise Time		--	10	--	nS
$t_{\text{d(off)}}$	Turn-Off Delay Time		--	22	--	nS
t_f	Turn-Off Fall Time		--	7	--	nS
Source- Drain Diode Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise stated)						
V_{SD}	Forward on voltage	$I_{\text{SD}}=15\text{A}, V_{\text{GS}}=0\text{V}$	--	0.9	1.2	V
t_{rr}	Reverse Recovery Time	$T_J=25^\circ\text{C}, I_{\text{SD}}=15\text{A}, V_{\text{GS}}=0\text{V}$ $dI/dt=500\text{A}/\mu\text{s}$	--	9.5	--	nS
Q_{rr}	Reverse Recovery Charge		--	11.8	--	nC

NOTE:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Limited by $T_{J\text{max}}$, starting $T_J = 25^\circ\text{C}$, $L = 0.5\text{mH}$, $R_g = 25\Omega$, $I_{AS} = 6\text{A}$, $V_{GS} = 10\text{V}$. Part not recommended for use above this value
- ③ Pulse width $\leq 300\mu\text{s}$; duty cycle $\leq 2\%$.



Typical Characteristics

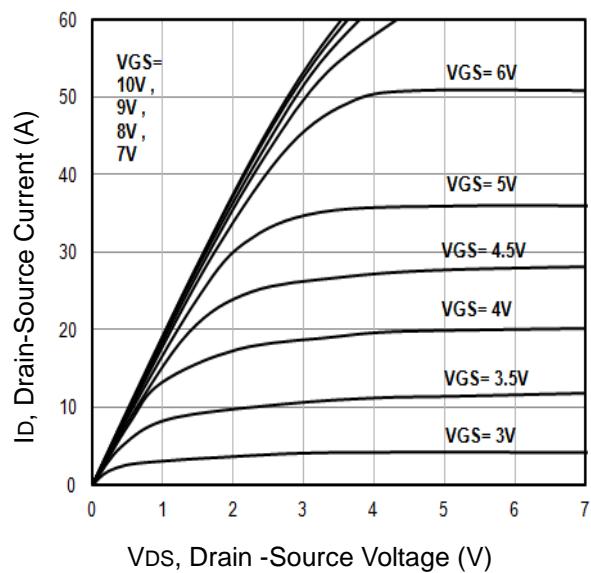


Fig1. Typical Output Characteristics

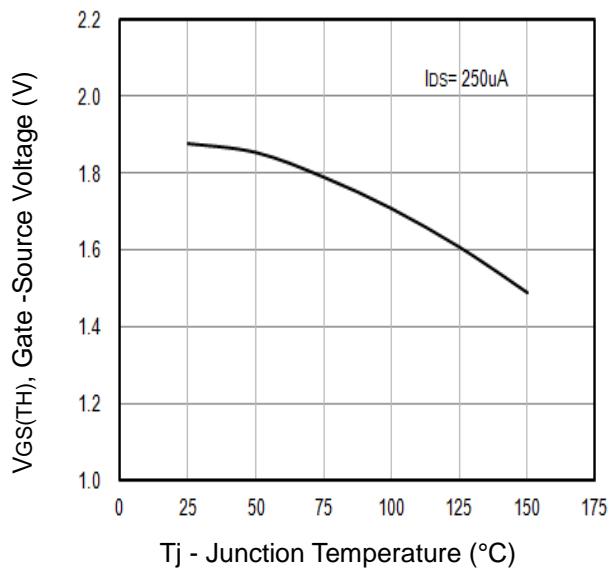


Fig2. Threshold Voltage Vs. Temperature

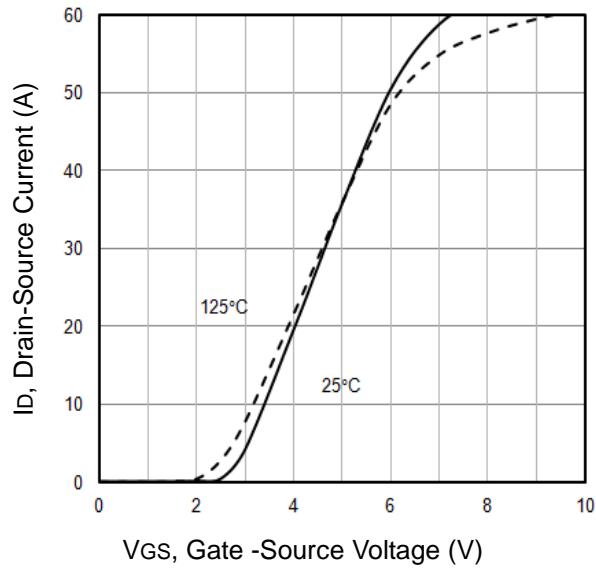


Fig3. Typical Transfer Characteristics

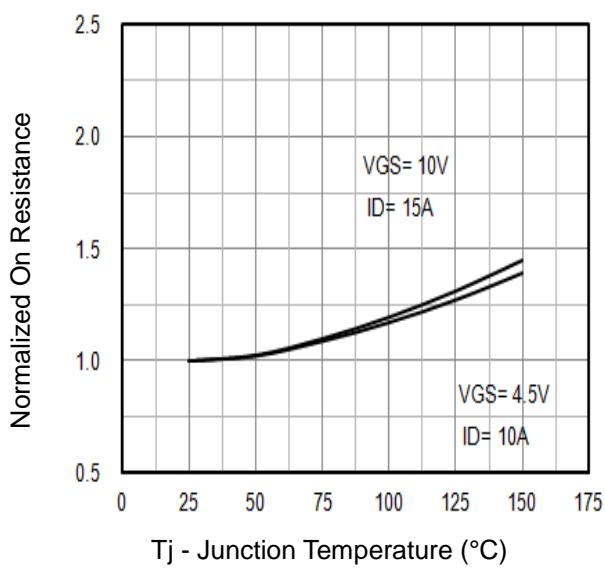


Fig4. Normalized On-Resistance Vs. Temperature

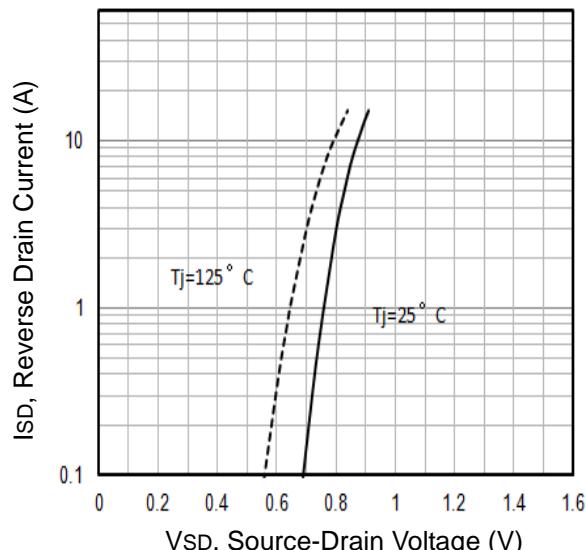


Fig5. Typical Source-Drain Diode Forward Voltage

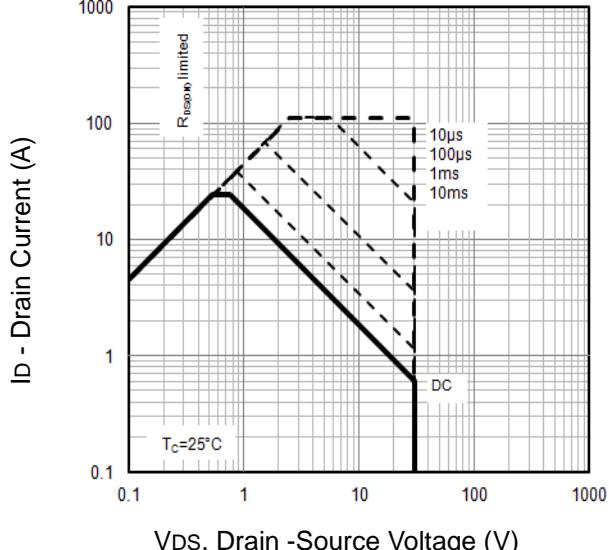


Fig6. Maximum Safe Operating Area



Typical Characteristics

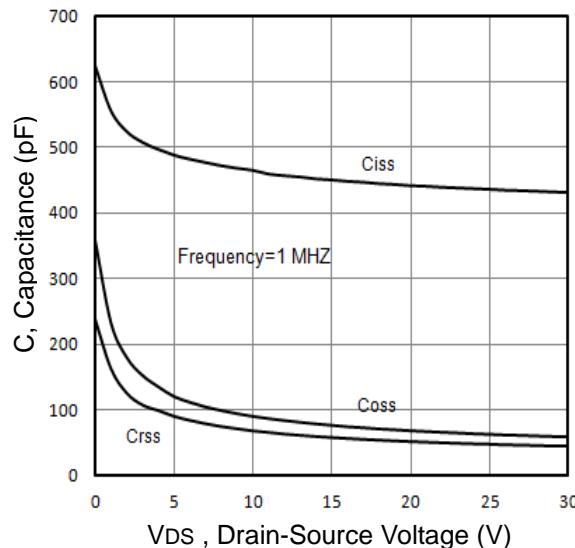


Fig7. Typical Capacitance Vs.Drain-Source Voltage

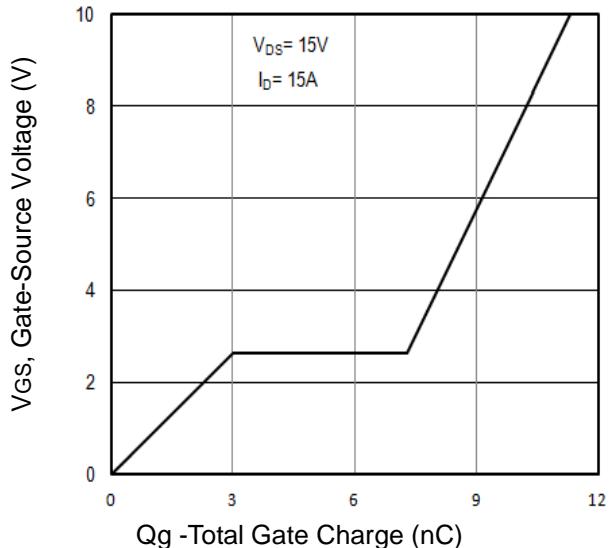


Fig8. Typical Gate Charge Vs.Gate-Source Voltage

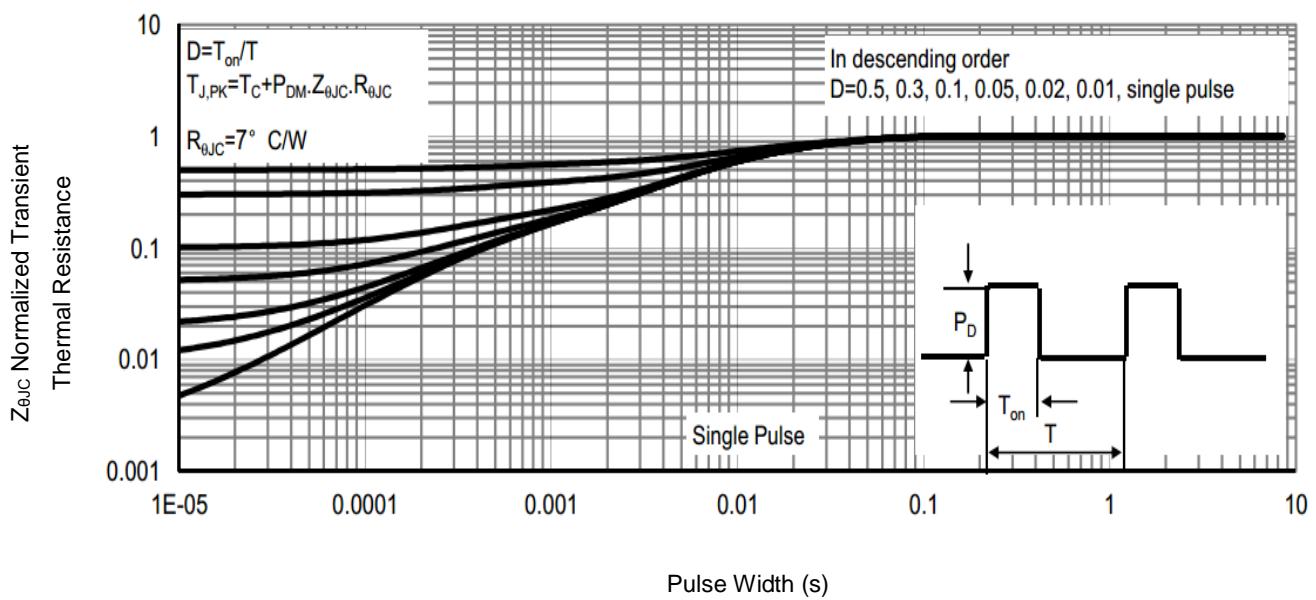


Fig9. Normalized Maximum Transient Thermal Impedance

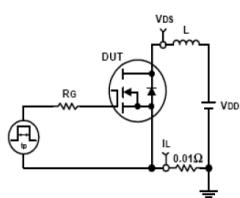


Fig10. Unclamped Inductive Test Circuit and waveforms

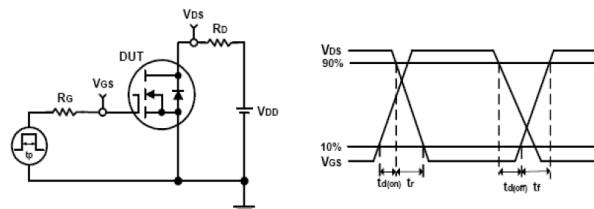
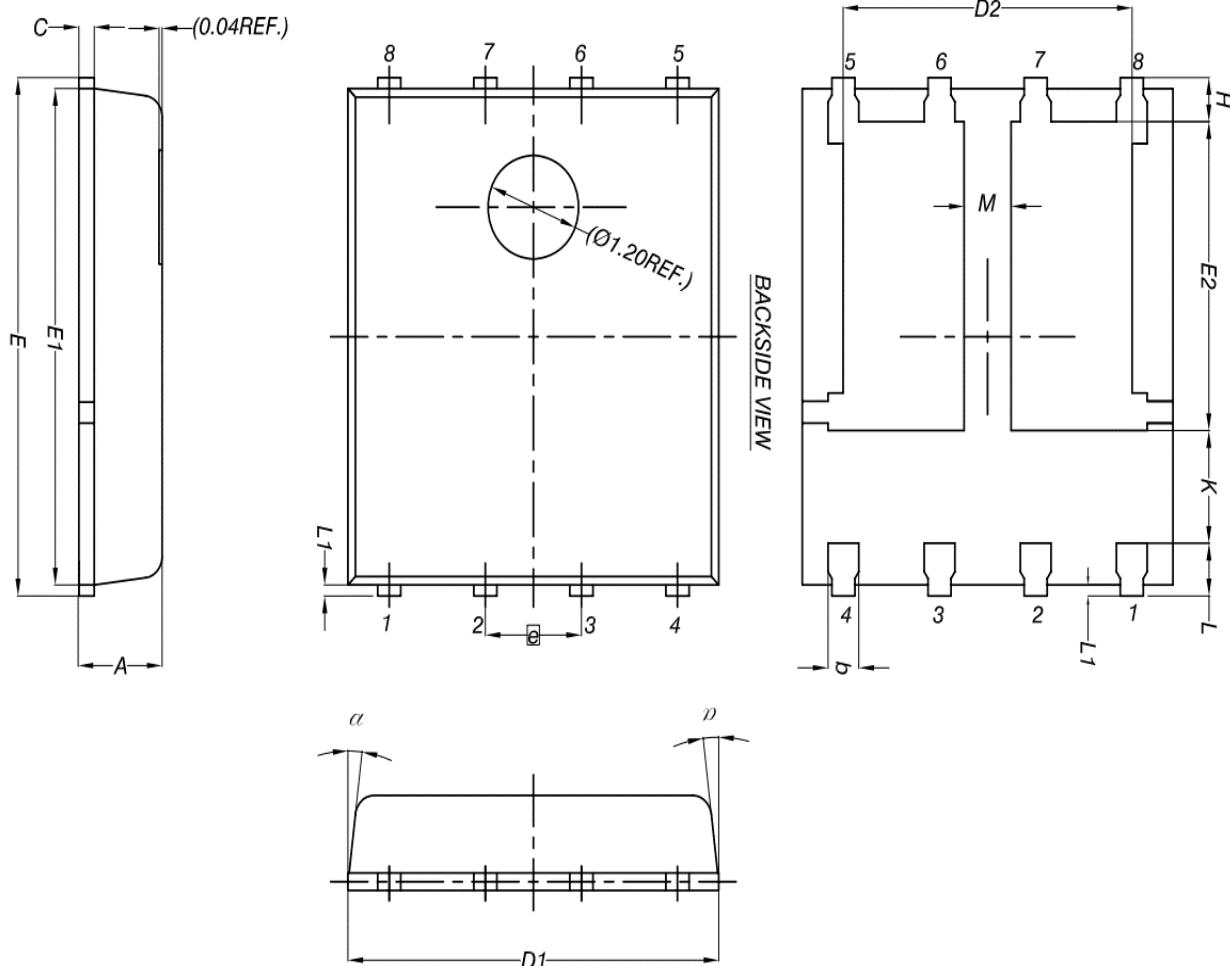


Fig11. Switching Time Test Circuit and waveforms



Dual DFN5x6 Package Outline Data



Symbol	DIMENSIONS (unit : mm)		
	Min	Typ	Max
A	0.9	1	1.1
b	0.33	0.41	0.51
C	0.2	0.25	0.3
D1	4.8	4.9	5
D2	3.61	3.81	3.96
E	5.9	6	6.1
E1	5.7	5.75	5.8
E2	3.38	3.58	3.78
e	1.27 BSC		
H	0.41	0.51	0.61
K	1.1	--	--
L	0.51	0.61	0.71
L1	0.06	0.13	0.2
M	0.5	--	--
alpha	0°	--	12°

Notes:

- Refer to JEDEC MO-240 variation AA.
- Dimensions "D1" and "E1" do NOT include mold flash protrusions or gate burrs.
- Dimensions "D1" and "E1" include interterminal flash or protrusion. Interterminal flash or protrusion shall not exceed 0.25mm per side.

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